

Notice of References Cited

Application/Control No.

09/843,358

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

Nhan T Le

Art Unit

2685

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,307,541	10-2001	Ho et al.	345/171
	B	US-2001/0044724	11-2001	HON et al.	704/260
	C	US-6,292,772	09-2001	Kantrowitz, Mark	704/9
	D	US-6,272,464	08-2001	Kiraz et al.	704/257
	E	US-6,674,372	01-2004	Ouyang, Yen I	341/28
	F	US-6,686,852	02-2004	Guo, Jin	341/22
	G	US-6,009,444	12-1999	Chen, Xixian	715/535
	H	US-6,636,163	10-2003	Hsieh, Hsien-Fen	341/28
	I	US-4,531,119	07-1985	Nakayama et al.	345/171
	J	US-5,987,447	11-1999	Chang et al.	707/3
	K	US-5,838,972	11-1998	Matsuzuka et al.	719/332
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.